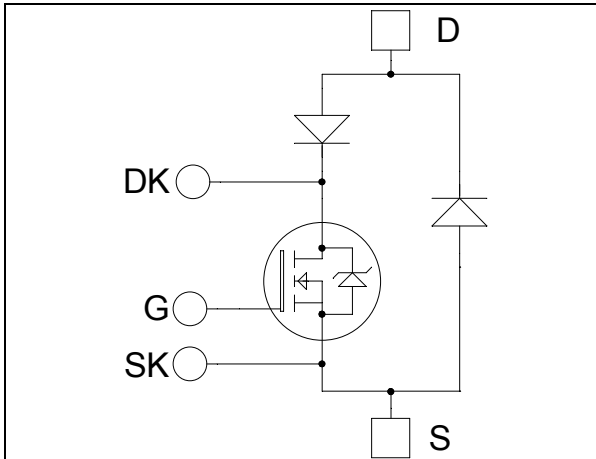
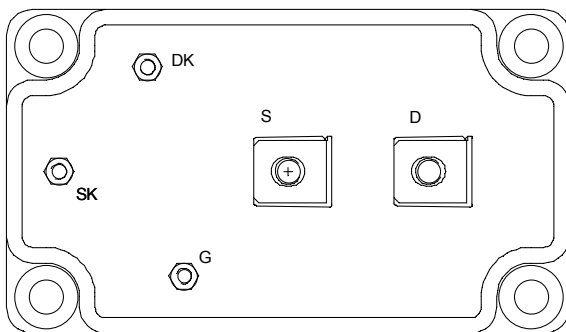


**Single switch
Series & SiC parallel diodes
MOSFET Power Module**

$V_{DSS} = 1200V$
 $R_{DSon} = 100m\Omega$ typ @ $T_j = 25^\circ C$
 $I_D = 116A$ @ $T_c = 25^\circ C$



G, SK and DK terminals are for control signals only (not for power)



Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

Features

- **Power MOS 7[®] MOSFETs**
 - Low R_{DSon}
 - Low input and Miller capacitance
 - Low gate charge
 - Avalanche energy rated
 - Very rugged
- **SiC Parallel Schottky Diode**
 - Zero reverse recovery
 - Zero forward recovery
 - Temperature Independent switching behavior
 - Positive temperature coefficient on VF
- Kelvin source for easy drive
- Kelvin drain for voltage monitoring
- Very low stray inductance
 - Symmetrical design
 - M5 power connectors
 - M3 power connectors
- High level of integration
- AlN substrate for improved MOSFET thermal performance

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Low profile
- RoHS Compliant

All ratings @ $T_j = 25^\circ C$ unless otherwise specified

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
V _{DSS}	Drain - Source Breakdown Voltage	1200	V
I _D	Continuous Drain Current	T _c = 25°C	116
		T _c = 80°C	86
I _{DM}	Pulsed Drain current	464	A
V _{GS}	Gate - Source Voltage	±30	V
R _{DS(on)}	Drain - Source ON Resistance	120	mΩ
P _D	Maximum Power Dissipation	T _c = 25°C	3290
I _{AR}	Avalanche current (repetitive and non repetitive)	24	A
E _{AR}	Repetitive Avalanche Energy	50	mJ
E _{AS}	Single Pulse Avalanche Energy	3200	

Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I _{DSS}	Zero Gate Voltage Drain Current	V _{GS} = 0V, V _{DS} = 1200V T _j = 25°C			1	mA
		V _{GS} = 0V, V _{DS} = 1000V T _j = 125°C			3	
R _{DS(on)}	Drain – Source on Resistance	V _{GS} = 10V, I _D = 58A		100	120	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{GS} = V _{DS} , I _D = 20mA	3		5	V
I _{GSS}	Gate – Source Leakage Current	V _{GS} = ±30 V, V _{DS} = 0V			±400	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C _{iss}	Input Capacitance	V _{GS} = 0V V _{DS} = 25V f = 1MHz		28.9		nF
C _{oss}	Output Capacitance			4.4		
C _{rss}	Reverse Transfer Capacitance			0.8		
Q _g	Total gate Charge	V _{GS} = 10V V _{Bus} = 600V I _D = 116A		1100		nC
Q _{gs}	Gate – Source Charge			128		
Q _{gd}	Gate – Drain Charge			716		
T _{d(on)}	Turn-on Delay Time	Inductive switching @ 125°C V _{GS} = 15V V _{Bus} = 800V I _D = 116A R _G = 1.2Ω		20		ns
T _r	Rise Time			17		
T _{d(off)}	Turn-off Delay Time			245		
T _f	Fall Time			62		
E _{on}	Turn-on Switching Energy	Inductive switching @ 25°C V _{GS} = 15V, V _{Bus} = 800V I _D = 116A, R _G = 1.2Ω		3		mJ
E _{off}	Turn-off Switching Energy			4.6		
E _{on}	Turn-on Switching Energy	Inductive switching @ 125°C V _{GS} = 15V, V _{Bus} = 800V I _D = 116A, R _G = 1.2Ω		5.5		mJ
E _{off}	Turn-off Switching Energy			5.6		
R _{thJC}	Junction to Case Thermal Resistance				0.038	°C/W

Series diode ratings and characteristics

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>		<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			1000			V
I _{RM}	Maximum Reverse Leakage Current	V _R =1000V				500	μA
I _F	DC Forward Current		T _c = 100°C		240		A
V _F	Diode Forward Voltage	I _F = 240A			1.9	2.5	V
		I _F = 480A			2.2		
		I _F = 240A	T _j = 125°C		1.7		
t _{rr}	Reverse Recovery Time	I _F = 240A V _R = 667V di/dt = 800A/μs	T _j = 25°C		280		ns
			T _j = 125°C			350	
Q _{rr}	Reverse Recovery Charge	I _F = 240A V _R = 667V di/dt = 800A/μs	T _j = 25°C		3		μC
			T _j = 125°C			14.4	
R _{thJC}	Junction to Case Thermal Resistance					0.19	°C/W

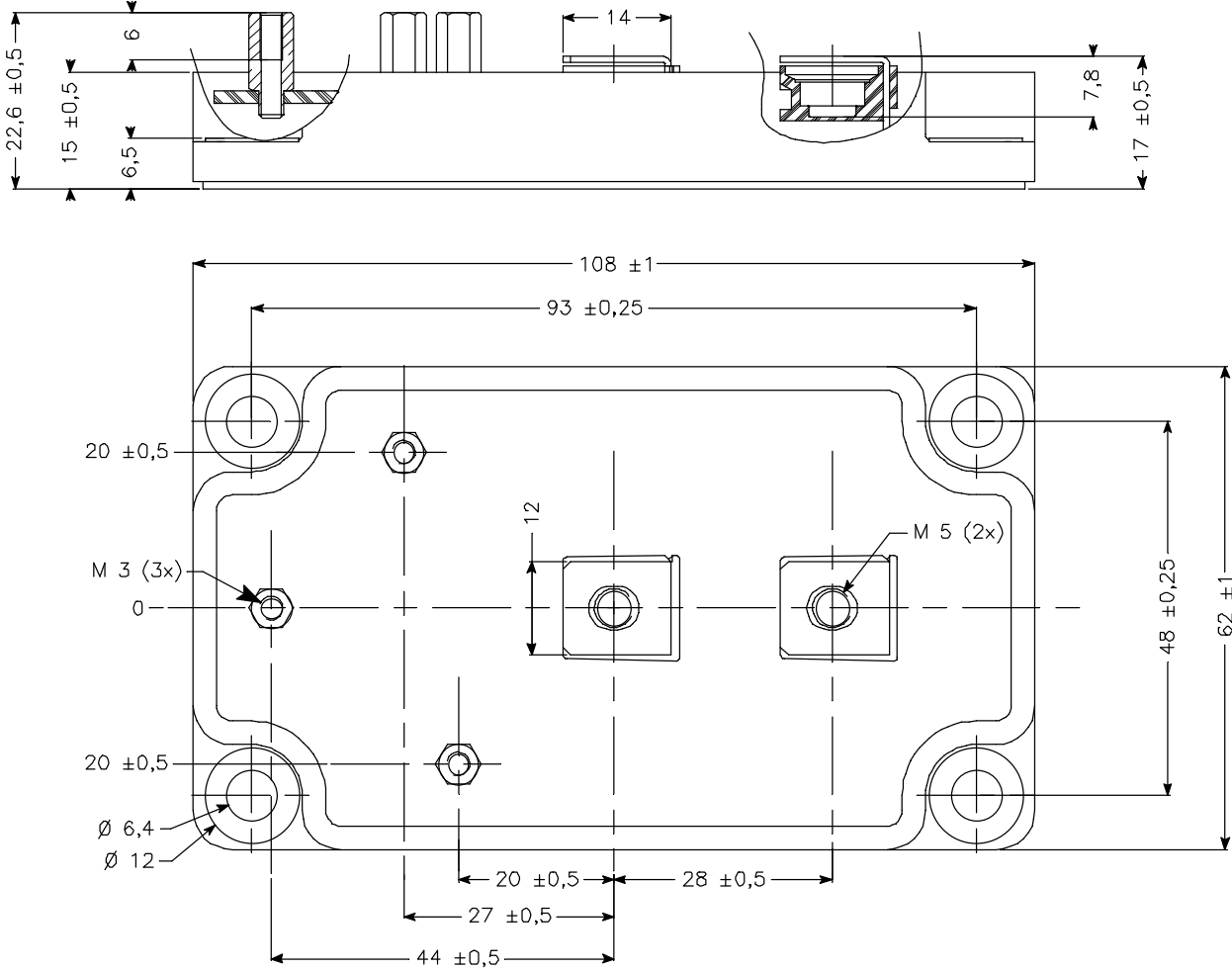
SiC Parallel diode ratings and characteristics

<i>Symbol</i>	<i>Characteristic</i>	<i>Test Conditions</i>		<i>Min</i>	<i>Typ</i>	<i>Max</i>	<i>Unit</i>
V _{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I _{RM}	Maximum Reverse Leakage Current	V _R =1200V	T _j = 25°C		288	1800	μA
			T _j = 175°C			504	
I _F	DC Forward Current		T _c = 100°C		90		A
V _F	Diode Forward Voltage	I _F = 90A	T _j = 25°C		1.6	1.8	V
			T _j = 175°C			2.3	
Q _C	Total Capacitive Charge	I _F = 90A, V _R = 1200V di/dt = 4500A/μs			720		nC
C	Total Capacitance	f = 1MHz, V _R = 200V			864		pF
		f = 1MHz, V _R = 400V			621		
R _{thJC}	Junction to Case Thermal Resistance					0.22	°C/W

Thermal and package characteristics

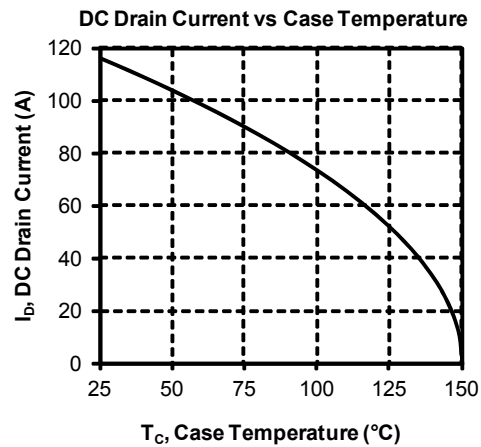
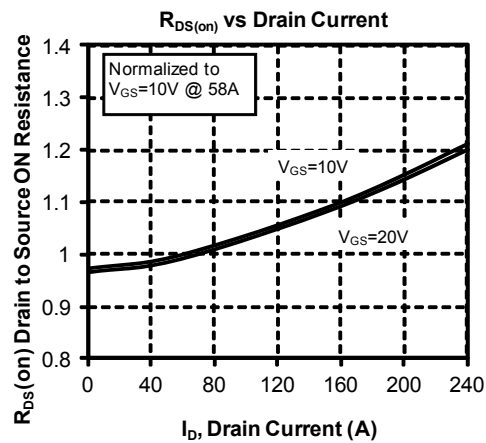
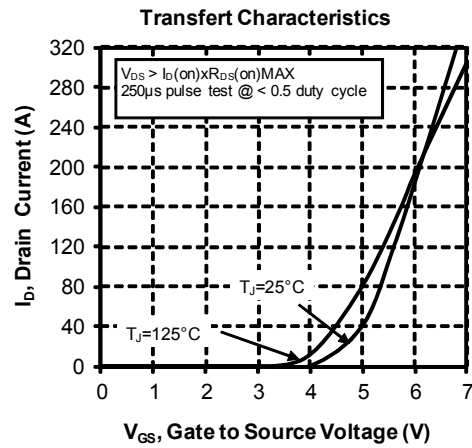
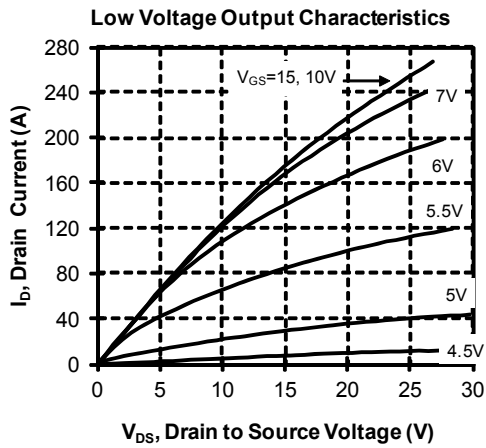
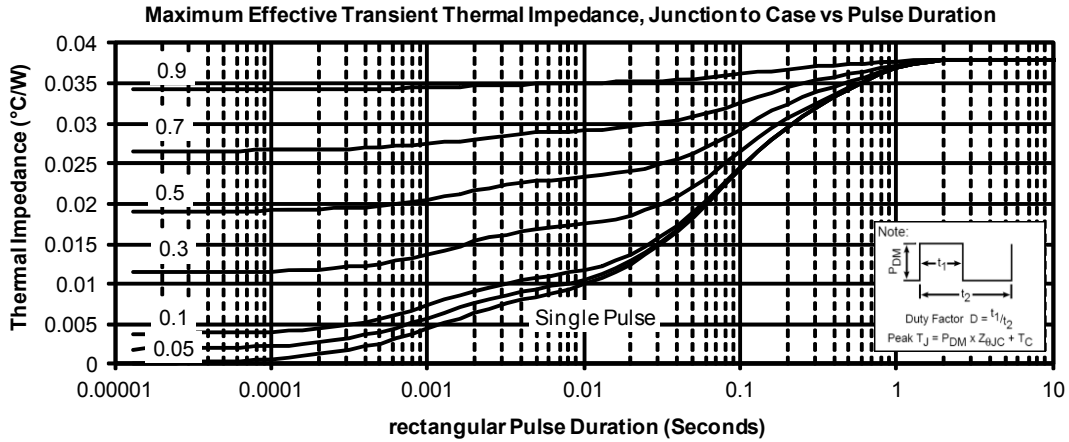
<i>Symbol</i>	<i>Characteristic</i>			<i>Min</i>	<i>Max</i>	<i>Unit</i>
V _{ISOL}	RMS Isolation Voltage, any terminal to case t=1 min, 50/60Hz			4000		V
T _J	Operating junction temperature range			-40	150	°C
T _{JOP}	Recommended junction temperature under switching conditions			-40	T _{jmax} -25	
T _{STG}	Storage Temperature Range			-40	125	
T _C	Operating Case Temperature			-40	100	
Torque	Mounting torque	To heatsink	M6	3	5	N.m
		For terminals	M5	2	3.5	
			M3	1	1.5	
Wt	Package Weight				300	g

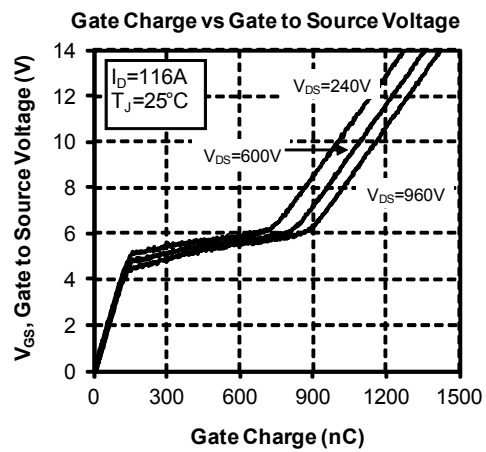
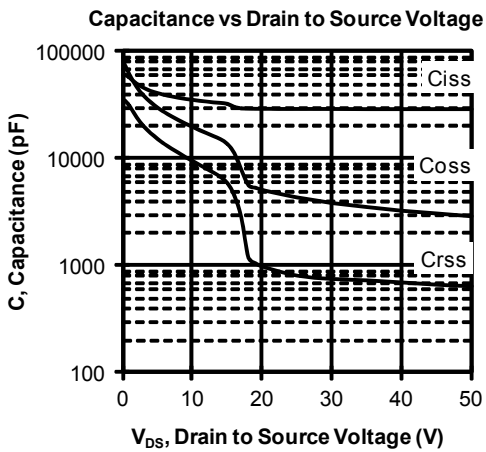
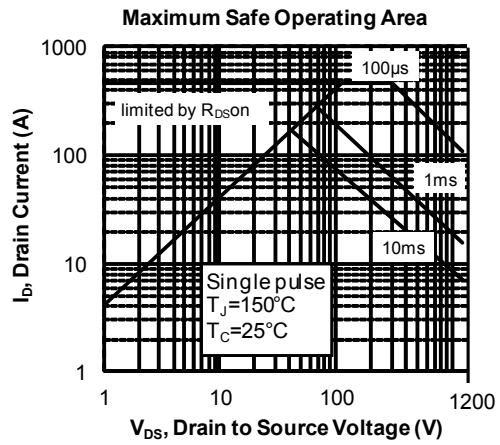
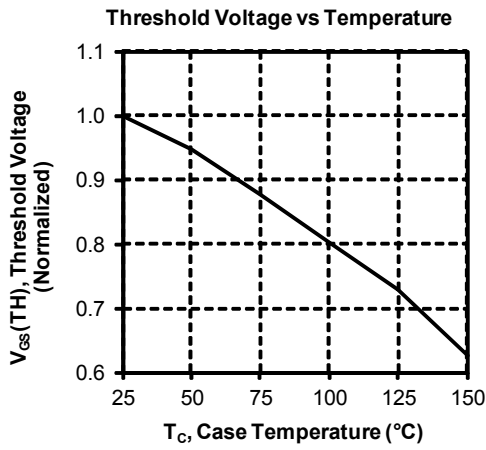
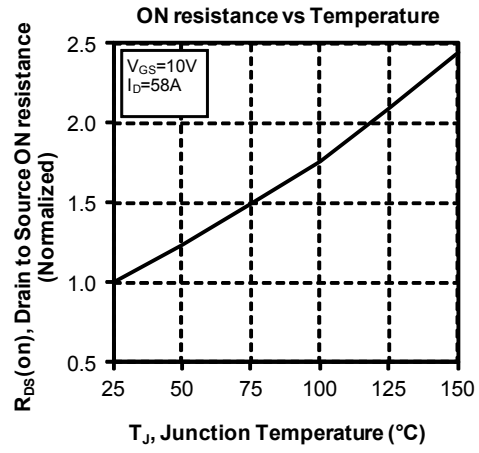
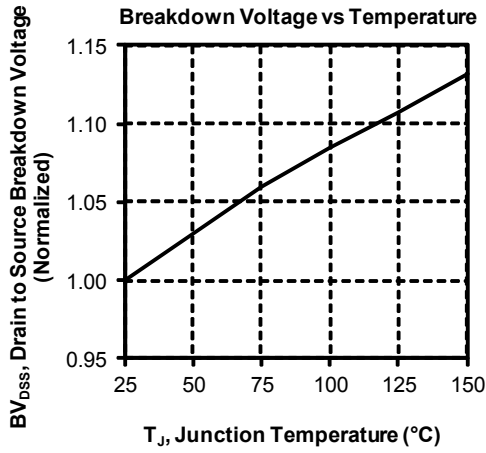
SP6 Package outline (dimensions in mm)

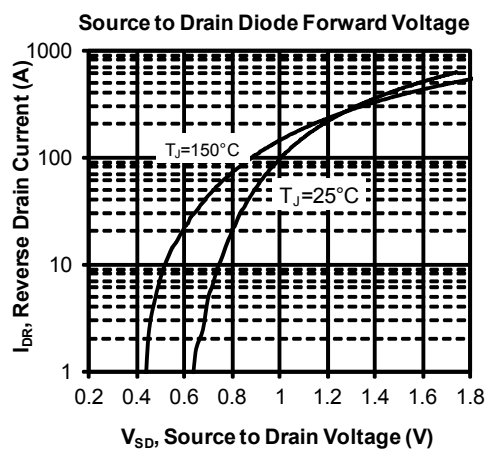
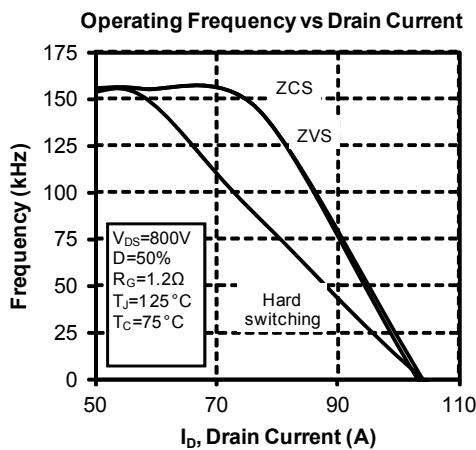
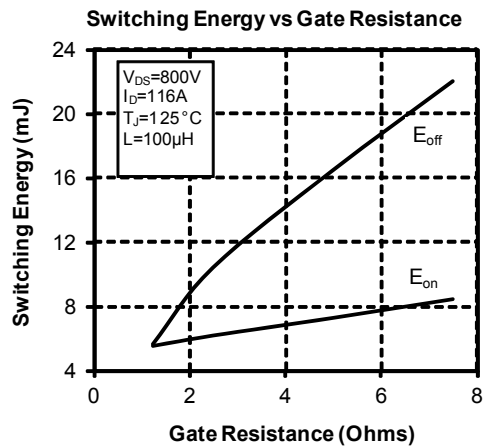
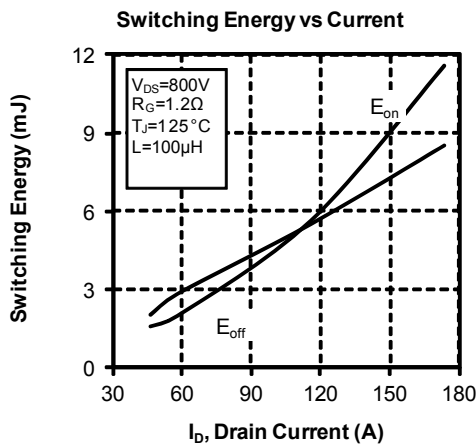
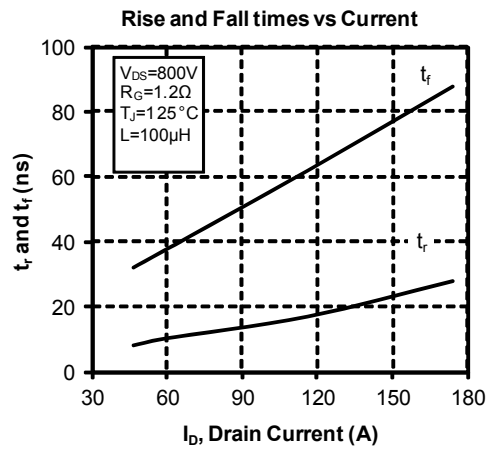
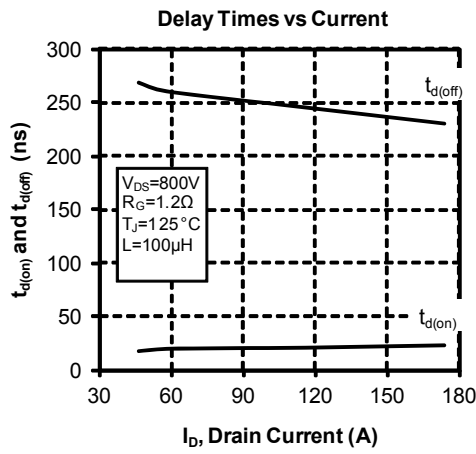


See application note APT0601 - Mounting Instructions for SP6 Power Modules on www.microsemi.com

Typical MOSFET Performance Curve

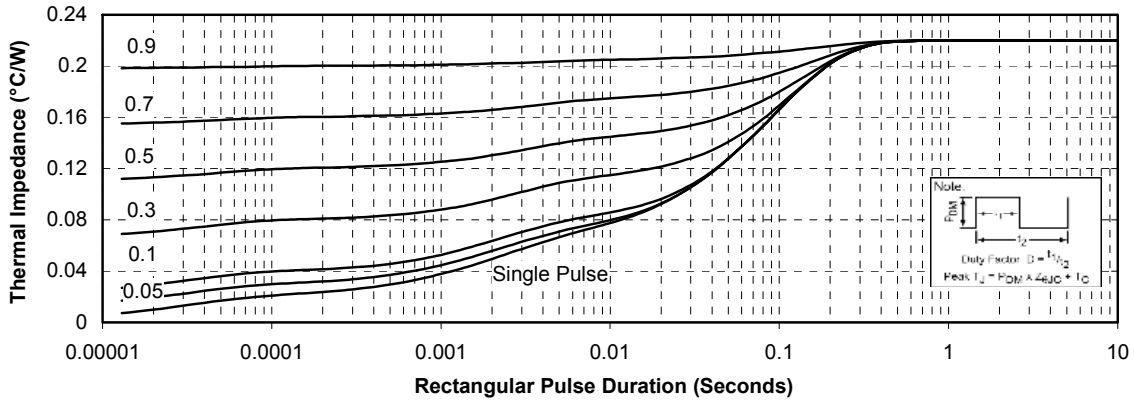




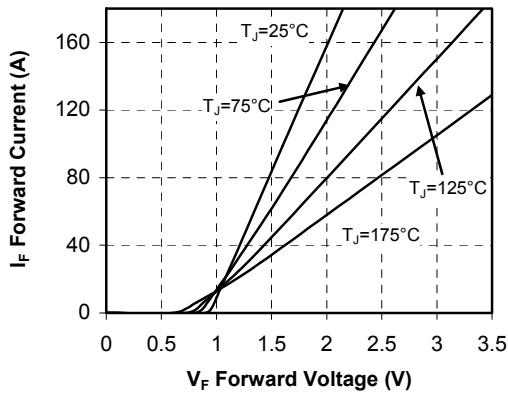


SiC Typical Performance Curve

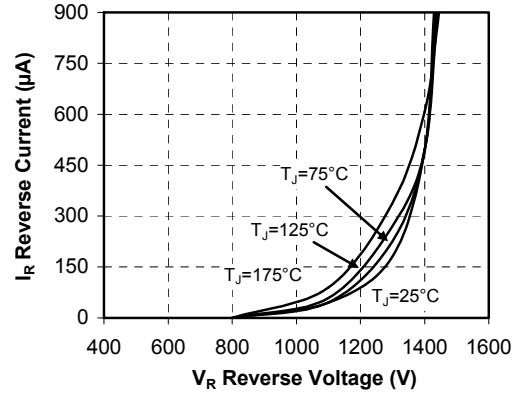
Maximum Effective Transient Thermal Impedance, Junction to Case vs Pulse Duration



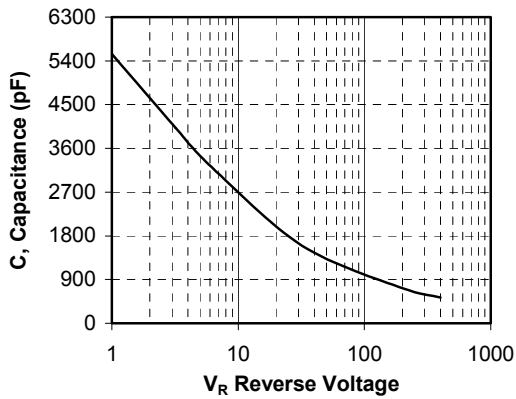
Forward Characteristics



Reverse Characteristics



Capacitance vs. Reverse Voltage



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